

Search Notes

Application/Control No.

09/945,171

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

SMITH ET AL.

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
375	297	2/27/2006	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only— see search history printout)	2/27/2006	EMF
375/295,296.ccls. (cursory)	2/27/2006	EMF
327/291.ccls. (cursory)	2/27/2006	EMF